

Search Notes

Application/Control No.

10/734,226

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search (UPDATED)	11/28/2005	EC
EAST (all databases) (UPDATED) - see search history printout	11/28/2005	EC
438/3,706,710,719,720,911 (text search only) (UPDATED)	11/28/2005	EC